

<b>Notice of References Cited</b>	Application/Control No. 10/081,699	Applicant(s)/Patent Under Reexamination NAKAMURA, MITSUTOSHI	
	Examiner James A. Dudek	Art Unit 2871	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,524,759 B1	02-2003	Sugimoto et al.	349/2
	B	US-			
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**NON-PATENT DOCUMENTS**

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